

Notice of References Cited

Application/Control No.

10/517,540

Applicant(s)/Patent Under
Reexamination
KAHLMAN ET AL.

Examiner

TAN X. DINH

Art Unit

2627

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,652,838 A	07-1997	Lovett et al.	726/30
*	B	US-5,790,489 A	08-1998	O'Connor, Clint H.	369/52.1
*	C	US-2002/0024905 A1	02-2002	Kahlman et al.	369/52.1
*	D	US-2003/0218073 A1	11-2003	Arimura, Kunitaka	235/492
*	E	US-7,070,101 B2	07-2006	Deguchi et al.	235/451
*	F	US-7,164,344 B2	01-2007	Deguchi et al.	340/10.51
*	G	US-7,230,537 B2	06-2007	Ishibashi, Hiromichi	340/572.7
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.